Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/711,990	FUJISAKI, IWAO	
Examiner	Art Unit	
Charles N. Appiah	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
455	12.1,13.2, 13.3,188.1 ,266,427	6/27/2006	CA		
	428,431				
725	67,72,76				
370	316,321				
	511				
380	13,212				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	,			
	ned Search port	6/27/2006	CA	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
455/12.1,13.2,13.3,188.1,266,427,428 ,431	6/27/2006	CA		
725/67,72,76				
370/316,321,511				
380/13,212				